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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/044,493	01/11/2002	Bin Yu	G0615	9266

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M. David Galin
Renner, Otto, Boisselle & Sklar, LLP
Nineteenth Floor
1621 Euclid Avenue,
Cleveland, OH 44115

EXAMINER

QUINTO, KEVIN V

ART UNIT PAPER NUMBER

2826

DATE MAILED: 12/04/2002

Please find below and/or attached an Office communication concerning this application or proceeding.

Offic Action Summary	Application No.	Applicant(s)
	10/044,493	YU ET AL.
	Examiner Kevin Quinto	Art Unit 2826

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Peri d for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) Responsive to communication(s) filed on 18 September 2002.
- 2a) This action is FINAL. 2b) This action is non-final.
- 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) Claim(s) 1-10 and 20 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) Claim(s) _____ is/are allowed.
- 6) Claim(s) 1-10 and 20 is/are rejected.
- 7) Claim(s) _____ is/are objected to.
- 8) Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) The specification is objected to by the Examiner.
- 10) The drawing(s) filed on _____ is/are: a) accepted or b) objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- 11) The proposed drawing correction filed on _____ is: a) approved b) disapproved by the Examiner.
If approved, corrected drawings are required in reply to this Office action.
- 12) The oath or declaration is objected to by the Examiner.

Pri rity under 35 U.S.C. §§ 119 and 120

- 13) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) All b) Some * c) None of:
1. Certified copies of the priority documents have been received.
 2. Certified copies of the priority documents have been received in Application No. _____.
 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.
- 14) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).
- a) The translation of the foreign language provisional application has been received.
- 15) Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.

Attachment(s)

- | | |
|--|---|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413) Paper No(s). _____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO-1449) Paper No(s) _____ | 6) <input type="checkbox"/> Other: _____ |

DETAILED ACTION

Response to Arguments

1. Applicant's arguments with respect to claims 1-10 and 20 have been considered but are moot in view of the new ground(s) of rejection.

Drawings

2. The drawings filed on January 1, 2002, are acceptable.

Claim Rejections - 35 USC § 102

3. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

(e) the invention was described in–

(1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effect under this subsection of a national application published under section 122(b) only if the international application designating the United States was published under Article 21(2)(a) of such treaty in the English language; or

(2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that a patent shall not be deemed filed in the United States for the purposes of this subsection based on the filing of an international application filed under the treaty defined in section 351(a).

4. Claims 1-4, 8, 9, and 20 are rejected under 35 U.S.C. 102(b) as being anticipated by Wilting (USPN 4,080,719).

5. In reference to claims 1 and 2, Wilting (USPN 4,080,719) discloses a similar device.

Figure 16 illustrates a MOSFET with a source (31) and a drain (32). Wilting discloses that the

source and drain regions (31, 32) are entirely silicide (column 7, lines 46-47); thus meeting and exceeding the “essentially of silicide” limitation. There is a semiconductor body disposed between the source (22) and the drain (23). There is a gate electrode (16A) disposed over the body; it is understood that the gate electrode (16A) defines a channel between the source (31) and the drain (32). There is a gate dielectric (4A, 4B), made of silicon oxide (4A) and silicon nitride (4B), which separates the gate electrode (16A) and the body. The silicon oxide – silicon nitride material is a well-known high-K or high dielectric film (see Lee, USPN 5,693,554, column 5, lines 30-31).

6. With regard to claims 3 and 4, Wilting discloses that the gate electrode (16A) is made of platinum silicide (column 6, lines 18-32) and can be made of other metal containing materials (column 7, lines 61-65).

7. In reference to claim 8, Wilting discloses the use of nickel silicide (column 7, lines 61-65) for the source and drain (31, 32). It is understood that the layer of semiconductor material, which is a part of the metal silicide, is a part of the body.

8. With regard to claim 9, figure 16 of Wilting shows that there is a liner (11) disposed adjacent or nearby sidewalls defined by the gate electrode (16A) and the gate dielectric (4A, 4B).

9. In reference to claim 20, figure 16 of Wilting shows that the silicide material of the source (31) and the semiconductor material of the body define a source/body junction. Figure 16 also shows that the silicide material of the drain (32) and the semiconductor material of the body define a drain/body junction.

Claim Rejections - 35 USC § 103

10. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

11. Claim 10 is rejected under 35 U.S.C. 103(a) as being unpatentable over Wilting (USPN 4,080,719) in view of Venkatesan et al. (USPN 5,736,435).

12. In reference to claim 10, Wilting does not disclose the use of an SOI substrate (a semiconductor film disposed on an insulating layer, the layer being disposed on a semiconductor substrate). However the use of an SOI substrate is well known in the art. Venkatesan et al. (USPN 5,736,435, hereinafter referred to as the “Venkatesan” reference) discloses that SOI provides the advantages of reduced junction capacitance, large drive currents, high transconductance values, and immunity to short channel effects (column 1, lines 35-55). It would therefore be obvious to construct the device of Wilting on an SOI substrate so as to attain these benefits.

13. Claims 1-5, 8, 9, and 20 are rejected under 35 U.S.C. 103(a) as being unpatentable over Grant et al. (USPN 6,423,619 B1) in view of Wilting (USPN 4,080,719).

14. In reference to claims 1, 2, and 5, Grant et al. (USPN 6,423,619 B1, hereinafter referred to as the “Grant” reference) discloses a similar device. Figure 6 illustrates a MOSFET with a source (14) and a drain (16). There is a semiconductor body (12) disposed between the source (14) and the drain (16). There is a gate electrode (24, 26, 28) disposed over the body (12); it is understood that the gate electrode (24, 26, 28) defines a channel between the source (14) and the

drain (16). There is a high-K gate dielectric (22), which can be made of hafnium oxide or zirconium oxide (column 2, lines 64-67), which separates the gate electrode (24, 26, 28) and the body (12). Grant does not disclose the use of source and drain regions entirely made of silicide. However Wilting (USPN 4,080,719) discloses a device in figure 16 which utilizes source and drain regions entirely made of nickel silicide (column 7, lines 61-65). Furthermore Wilting discloses that silicides provide good conductivity; which is desirable in the semiconductor art (column 1, lines 22-40 and column 7, lines 46-60). It would therefore be obvious to utilize source and drain regions entirely made of silicide.

15. With regard to claims 3 and 4, Grant discloses that the gate electrode (25, 26, 28) can be made of a titanium nitride, tantalum nitride, tungsten, aluminum, ruthenium, and platinum (column 3, lines 1-5, 14-17, 30-33).

16. In reference to claims 8 and 20, Wilting discloses the use of nickel silicide (column 7, lines 61-65) for the source and drain (31, 32) which is a part of a layer of semiconductor material which makes up the body. The device of Grant constructed in view of Wilting has a source/body junction defined by the silicide material of the source and the semiconductor material of the body. The device of Grant constructed in view of Wilting also has a drain/body junction defined by the silicide material of the drain and the semiconductor material of the body. Figure 16 also shows that the silicide material of the drain (32) and the semiconductor material of the body define a drain/body junction.

17. With regard to claim 9, figure 6 of Grant shows that there is a liner (18) disposed adjacent or nearby sidewalls defined by the gate electrode (24) and the gate dielectric (22).

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18. Claims 6 and 7 are rejected under 35 U.S.C. 103(a) as being unpatentable over Grant et al. (USPN 6,423,619 B1) in view of Wilting (USPN 4,080,719) as applied to claim 1 above and further in view of Raajimakers et al. (United States Patent Application Publication No. US 2001/0031562 A1).

19. In reference to claims 6 and 7, Grant does not disclose the use of an oxide buffer layer. However it is well known in the art to provide an oxide buffer layer between a substrate and a high dielectric constant insulating film. Raajimakers discloses that a thin silicon oxide layer improves the interface between silicon and a high dielectric constant film (p.1, paragraph 7 and p.3, paragraph 33). It would therefore be obvious to use an oxide buffer layer in the device of Grant so as to attain this benefit. Grant and Raajimakers teach all of the claimed invention except for the exact thickness of the oxide layer. Although Grant and Raajimakers do not teach the exact oxide thickness as that claimed by Applicant:

The shape, size, dimension differences are considered obvious design choices and are not patentable unless unobvious or unexpected results are obtained from these changes. It appears that these changes produce no functional differences and therefore would have been obvious. Note In re Leshin, 125 USPQ 416.

Therefore claim 7 is not patentably distinguishable over the Grant and Raajimakers references.

14. Claim 10 is rejected under 35 U.S.C. 103(a) as being unpatentable over Grant et al. (USPN 6,423,619 B1) in view of Wilting (USPN 4,080,719) as applied to claim 1 above and further in view of Venkatesan et al. (USPN 5,736,435).

15. In reference to claim 10, neither Grant nor Wilting discloses the use of an SOI substrate (a semiconductor film disposed on an insulating layer, the layer being disposed on a semiconductor substrate). However the use of an SOI substrate is well known in the art. Venkatesan et al. (USPN 5,736,435, hereinafter referred to as the "Venkatesan" reference) discloses that SOI provides the advantages of reduced junction capacitance, large drive currents,

high transconductance values, and immunity to short channel effects (column 1, lines 35-55). It would therefore be obvious to use an SOI substrate so as to attain these benefits in the device of Grant constructed in view of Wilting.

Conclusion

20. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Kevin Quinto whose telephone number is (703) 306-5688. The examiner can normally be reached on M-F 8AM-5PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Nathan Flynn can be reached on (703) 308-6601. The fax phone numbers for the

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organization where this application or proceeding is assigned are (703) 308-7722 for regular communications and (703) 308-7724 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0956.

KVQ
November 27, 2002

NATHAN J. FLYNN
SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 2800

